

PFP60R180 / PFF60R180

N-Channel Super Junction MOSFET

FEATURES

- New technology for high voltage device
- Low $R_{DS(on)}$ low conduction losses
- Small package
- Ultra low gate charge cause lower driving requirement
- 100% avalanche tested
- RoHS

$BV_{DSS} = 600\text{ V}$ $R_{DS(on)} = 0.15\ \Omega$ $I_D = 21\text{ A}$	
---	--

APPLICATION

- Power Factor Correction(PFC)
- Switched mode power supply (SMPS)
- Uninterruptible Power Supply (UPS)

TO-220 	TO-220F
-------------------	--------------------

Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	PFP60R180	PFF60R180	Units
V_{DS}	Drain-Source Voltage ($V_{GS}=0\text{V}$)	600		V
I_D	Drain Current – Continuous ($T_c = 25^\circ\text{C}$)	21	21*	A
	Drain Current – Continuous ($T_c = 100^\circ\text{C}$)	13.2	13.2*	A
$I_{DM(pulse)}$	Drain Current – Pulsed * Note 1	63	63*	A
V_{GS}	Gate-Source Voltage ($V_{DS}=0\text{V}$)	± 30		V
E_{AS}	Single Pulsed Avalanche Energy * Note 2	690		mJ
I_{AR}	Avalanche Current * Note 1	7.0		A
E_{AR}	Repetitive Avalanche Energy * Note 1	1.0		mJ
dv/dt	Drain Source Voltage Slope, $V_{DS} \leq 480\text{V}$	50		V/ns
	Reverse Diode dv/dt, $V_{DS} \leq 480\text{V}$	15		V/ns
P_D	Maximum Power Dissipation ($T_c = 25^\circ\text{C}$)	200	34	W
	Derate above 25°C	1.6	0.27	W/ $^\circ\text{C}$
T_I, T_{STG}	Operating and Storage Temperature Range	-55 to +150		$^\circ\text{C}$

* Limited by maximum junction temperature

Thermal Resistance Characteristics

Symbol	Parameter	PFP60R180	PFF60R180	Units
$R_{\theta JC}$	Junction-to-Case (Maximum)	0.62	3.67	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient (Maximum)	62	80	

Electrical Characteristics $T_A=25\text{ }^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	2.5	3.0	3.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 10.5\text{ A}$	--	150	180	m.ohm
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	600	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$	--	--	1	μA
		$V_{DS} = 600\text{ V}, T_C = 125\text{ }^\circ\text{C}$	--	--	100	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	--	--	-100	nA
Dynamic Characteristics						
g_{FS}	Forward Transconductance	$V_{DS} = 20\text{ V}, I_D = 10.5\text{ A}$	--	17.5	--	S
R_G	Intrinsic Gate Resistance	$f = 1.0\text{ MHz}$, open drain	--	1.0	--	ohm
C_{iss}	Input Capacitance	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	--	1950	--	pF
C_{oss}	Output Capacitance		--	150	--	pF
C_{rss}	Reverse Transfer Capacitance		--	5.0	--	pF
Q_g	Total Gate Charge	$V_{DS} = 480\text{ V}, I_D = 21\text{ A},$ $V_{GS} = 10\text{ V}$	--	45	70	nC
Q_{gs}	Gate-Source Charge		--	9	--	nC
Q_{gd}	Gate-Drain Charge		--	18	--	nC
Switching Characteristics						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 380\text{ V}, I_D = 11\text{ A},$ $R_G = 4\text{ }\Omega, V_{GS} = 10\text{ V}$	--	11	--	ns
t_r	Turn-On Rise Time		--	6	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	61	100	ns
t_f	Turn-Off Fall Time		--	4.5	12	ns
Source-Drain Diode Maximum Ratings and Characteristics						
I_S	Continuous Source-Drain Diode Forward Current		--	--	21	A
I_{SM}	Pulsed Source-Drain Diode Forward Current		--	--	63	
V_{SD}	Source-Drain Diode Forward Voltage	$I_S = 21\text{ A}, V_{GS} = 0\text{ V}$	--	0.9	1.3	V
t_{rr}	Reverse Recovery Time	$I_S = 21\text{ A}$	--	310	--	ns
Q_{rr}	Reverse Recovery Charge	$di/dt = 100\text{ A}/\mu\text{s}$	--	5	--	μC

Notes ;

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $V_{DD}=50\text{ V}, R_G=25\text{ }\Omega$, Starting $T_J=25\text{ }^\circ\text{C}$

Typical Characteristics

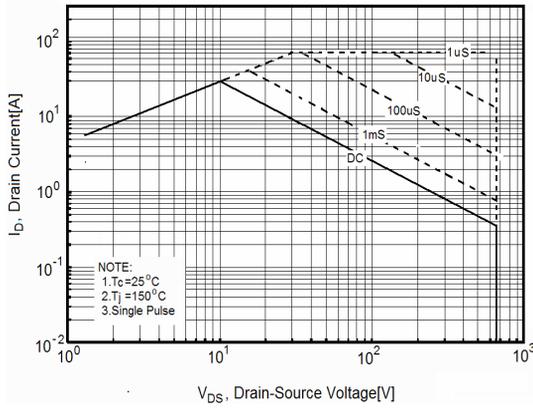


Figure 1. Safe Operating Area(TO-220)

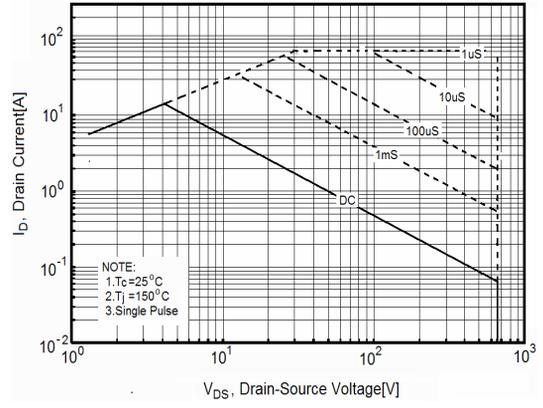


Figure 2. Safe Operating Area(TO-220F)

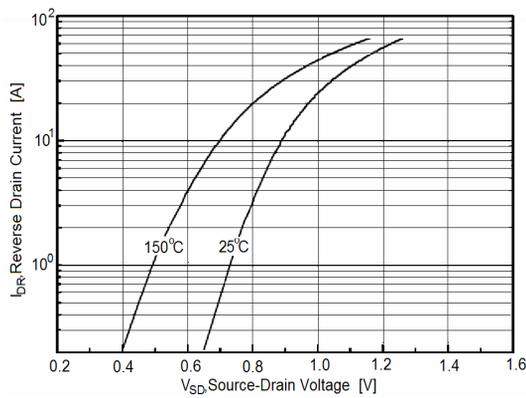


Figure 3. Source-Drain Diode Forward Voltage

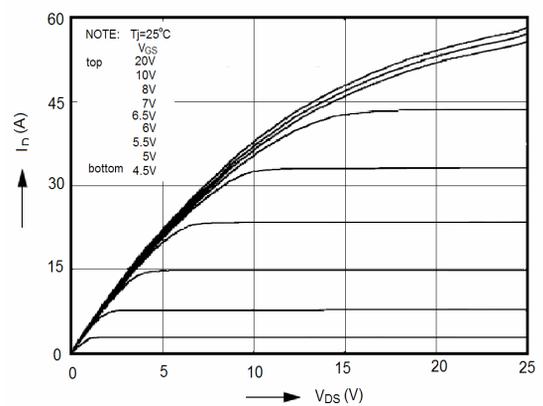


Figure 4. Output Characteristics

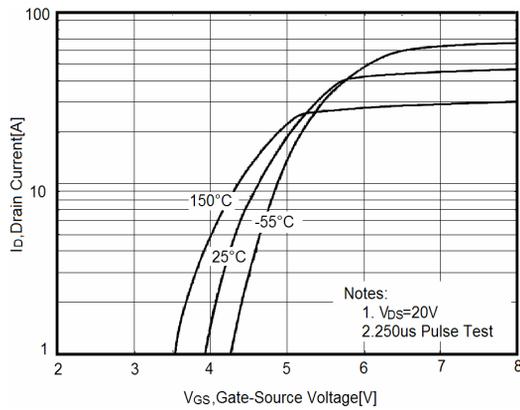


Figure 5. Transfer Characteristics

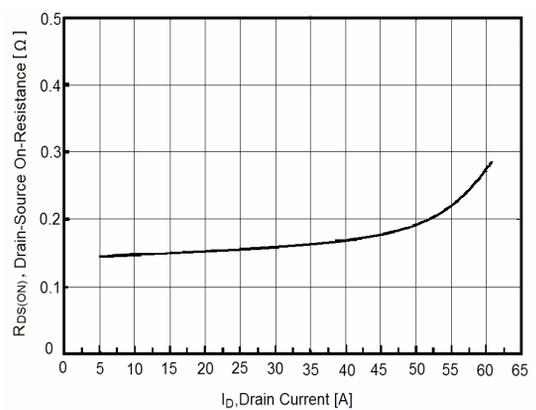


Figure 6. Static Drain-Source On Resistance

Typical Characteristics (continued)

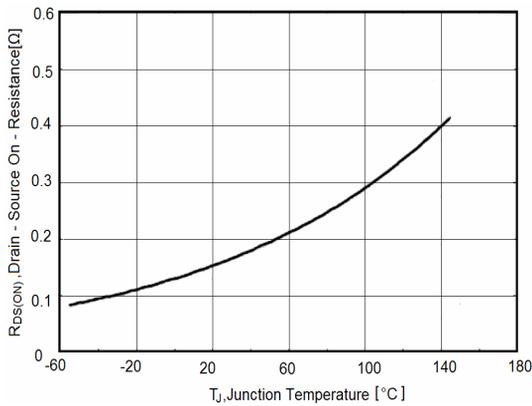


Figure 7. $R_{ds(on)}$ vs. Junction Temperature

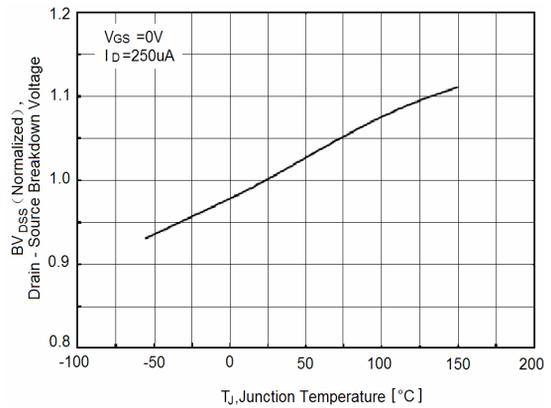


Figure 8. BV_{dss} vs. Junction Temperature

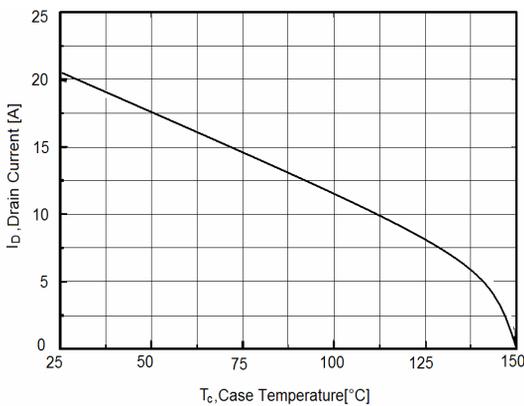


Figure 9. Maximum I_D vs. Junction Temperature

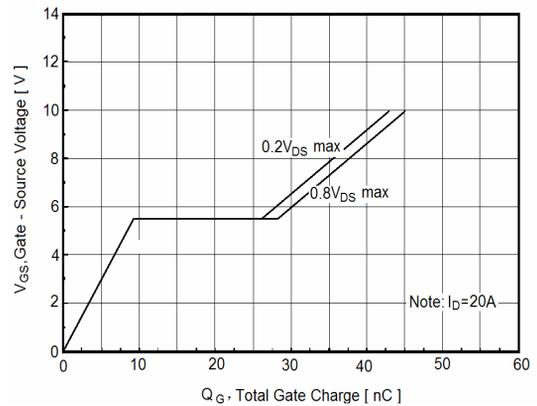


Figure 10. Gate Charge Waveforms

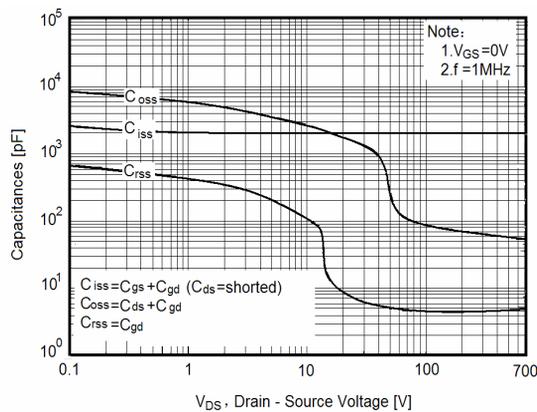


Figure 11. Capacitance

Typical Characteristics (continued)

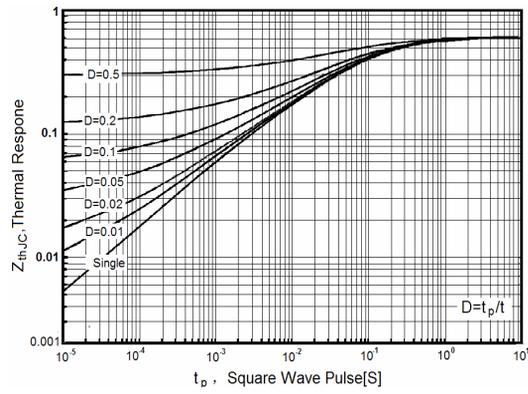


Figure 12. Transient Thermal Response Curve (TO-220)

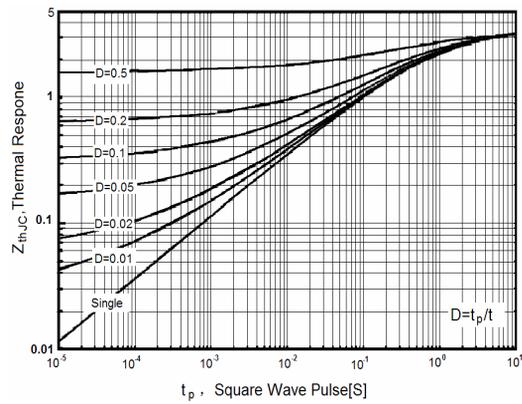
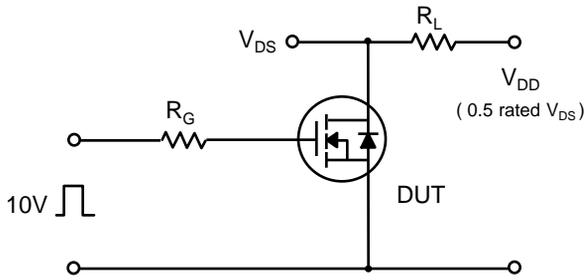
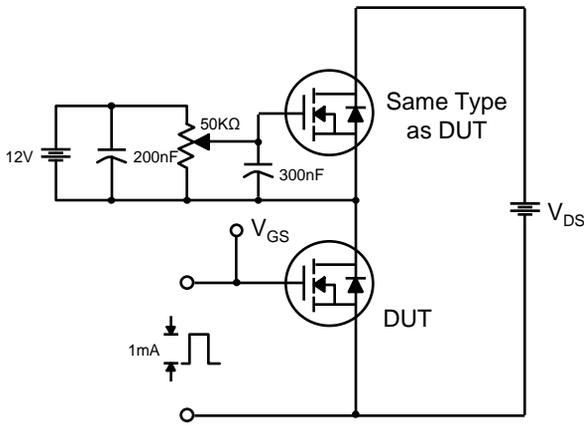


Figure 13. Transient Thermal Response Curve (TO-220F)

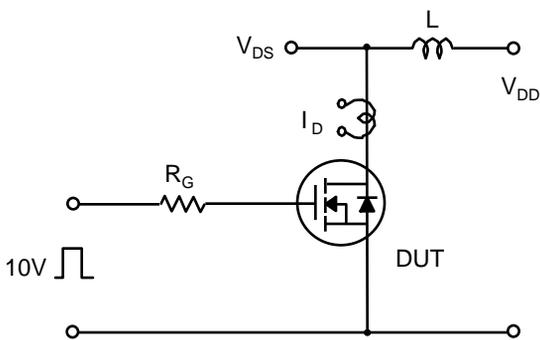
Characteristics Test Circuit & Waveform



Switching Time Test Circuit & Waveforms

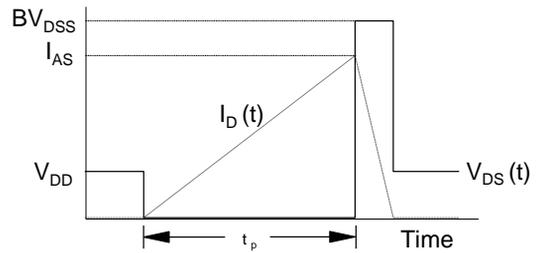


Gate Charge Test Circuit & Waveform

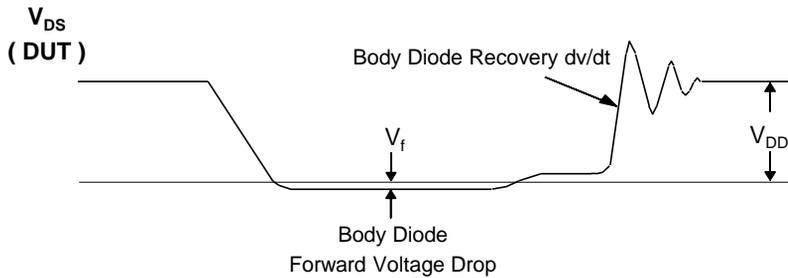
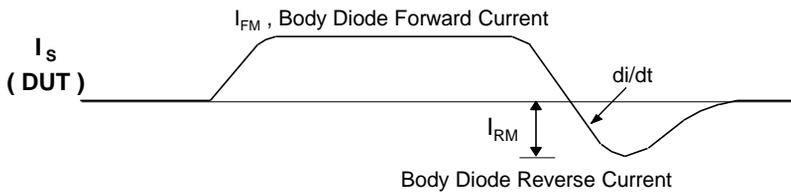
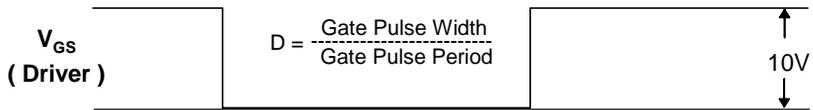
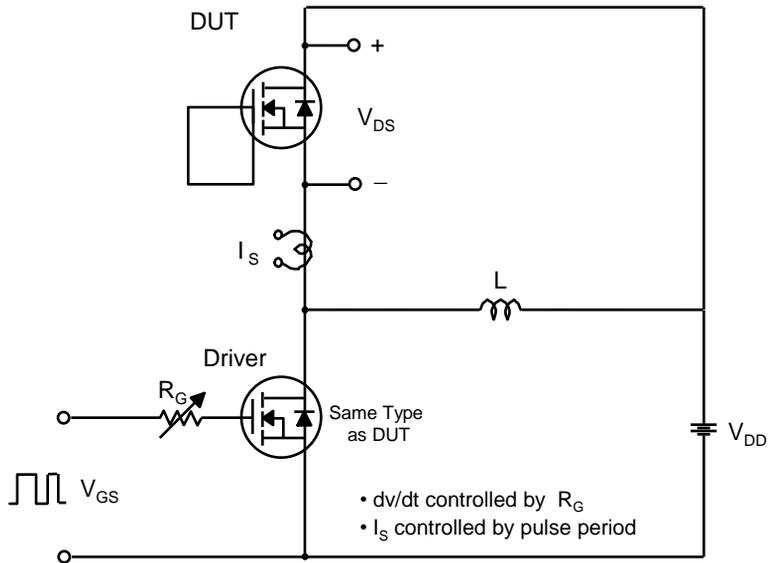


Unclamped Inductive Switching Test Circuit & Waveforms

$$E_{AS} = \frac{1}{2} L_L I_{AS}^2 \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$



Characteristics Test Circuit & Waveform (continued)



Peak Diode Recovery dv/dt Test Circuit & Waveforms

